

FCC TEST REPORT PART 2

(Test Under Dynamic Transmission Condition)

Application No.: SZCR2404001160WM
Applicant: vivo Mobile Communication Co., Ltd.
Manufacturer: vivo Mobile Communication Co., Ltd.
EUT Description: Mobile phone
Model No.: V2341
Trade Mark: vivo
FCC ID: 2AUCY-V2341
Standards: FCC 47CFR §2.1093
Date of Receipt: 2024/04/03
Date of Test: 2024/04/03 to 2024/05/10
Test conclusion: PASS



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

REVISION HISTORY

Report Number	Revision	Description	Issue Date
SZCR240400116010	01	Original	2024/05/10

Prepared By	 Vito Wang
Checked By	 Roman Pan



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

CONTENTS

1 Introduction	4
1.1 Details of Client.....	4
1.2 Test Lab Information	4
1.3 Bibliography	4
2 Tx Varying Transmission Test Cases and Test Proposal	5
3 SAR Time Averaging Validation Test Procedures	6
3.1 Test configuration selection criteria for validating Smart Transmit feature.....	6
3.1.1 Test configuration selection for change in time window	7
3.1.2 Test configuration selection for SAR exposure switching	8
3.2 Test procedures for conducted power measurements	9
3.2.1 Change in time window	9
3.2.2 SAR exposure switching.....	11
3.3 Test procedure for time-varying SAR measurements	12
4 Test Configurations	14
4.1 WWAN (sub-6) transmission	14
5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation	18
5.1 Measurement setup	18
5.2 Plimit and Pmax measurement results.....	21
5.3 Change in Time window.....	22
5.3.1 Test case 1: transition from NR N7 to NR N77 (i.e., 100s to 60s), then back to NR N7	22
5.3.2 Test case 1: transition from NR N78 to NR N41 (i.e., 60s to 100s), then back to NR N78	25
5.4 Switch in SAR exposure test results (EN-DC Combination)	28
5.5 Switch in SAR exposure test results (LTE Inter-Band Uplink CA)	31
6 Conclusions	34
7 Test Equipment List.....	35
Appendix A. Test Procedures for 5G NR + LTE Radio	35
Appendix C. Test Procedures for inter-band UL CA.....	38



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Standards Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

1 Introduction

The equipment under test (EUT) is a portable handset that supports the 2G/3G/4G/5G NR/BT/WLAN frequency band. It contains embedded file system (EFS) version 20 configured for Smart Tx 1st generation (GEN1), but only 2G/3G/4G/5G NR are enabled with Qualcomm Smart Transmit feature to control and manage transmitting power in real time and to ensure at all times the time-averaged RF exposure is in compliance with the FCC requirement. All WWAN band are configured for peak exposure mode, we verification the applicable cases in part2.

This purpose of the Part 2 report is to demonstrate the EUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm Smart Transmit feature for FCC equipment authorization.

1.1 Details of Client

Applicant:	vivo Mobile Communication Co., Ltd.
Address:	No.1, vivo Road, Chang'an, Dongguan, Guangdong, China
Manufacturer:	vivo Mobile Communication Co., Ltd.
Address:	No.1, vivo Road, Chang'an, Dongguan, Guangdong, China

1.2 Test Lab Information

Company:	SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch
Address:	No. 1 Workshop, M-10, Middle section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China
Post code:	518057
Test Engineer:	Vito Wang, Charley Yi

1.3 Bibliography

Report Type	Report No.
SZCR240400116009_FCC_SAR Report_part0	SZCR240400116009
SZCR240400116008_FCC_SAR Reportt_part1	SZCR240400116008



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 83071443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

2 Tx Varying Transmission Test Cases and Test Proposal

To validate time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in Part 2 test:

1. During time window switch: To prove that the Smart Transmit feature correctly handles the transition from one time window to another specified by FCC and maintains the normalized time-averaged RF exposure to be less than FCC limit of 1.0 at all times.
2. SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.

As described in Part 0 report, the RF exposure is proportional to the Tx power for a SAR-characterized wireless device. Thus, feature validation in Part 2 can be effectively performed through conducted (for $f < 6\text{GHz}$) measurement. Therefore, the compliance demonstration under dynamic transmission conditions and feature validation are done in conducted/radiated power measurement setup for transmission scenario 1 through 5.

Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_Plimit}} * 1g_or_10gSAR_Plimit \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC \text{ SAR limit}} \leq 1 \quad (1b)$$

where, $\text{conducted_Tx_power}(t)$, $\text{conducted_Tx_power_Plimit}$, and $1g_or_10gSAR_Plimit$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at Plimit, and measured 1gSAR or 10gSAR values at Plimit corresponding to sub-6 transmission. Plimit is the parameters pre-defined in Part 0 and loaded via Embedded File System (EFS) onto the EUT.

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR limit, through time-averaged SAR measurement. Note as mentioned earlier, this measurement is performed for transmission scenario 1 only.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

- For sub-6 transmission only, measure instantaneous SAR versus time; for LTE+5G NR transmission, request low power (or all-down bits) on LTE so that measured SAR predominantly corresponds to 5G NR.
- Convert it into RF exposure and divide by respective FCC limits to obtain normalized exposure versus time.
- Perform time averaging over FCC defined time window.
- Demonstrate that the total normalized time-averaged RF exposure is less than 1 for transmission scenario 1 at all times.

Mathematical expression:

– For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_Plimit} * 1g_or_10gSAR(t)_Plimit \quad (3a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (3b)$$

where, $pointSAR(t)$, $pointSAR_Plimit$, and $1g_or_10gSAR_Plimit$ correspond to the measured instantaneous point SAR, measured point SAR at Plimit, and measured 1gSAR or 10gSAR values at Plimit corresponding to sub-6 transmission.

Note: cDASY6 or Cdasy8 measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field and provides ratio of $\frac{[pointE(t)]^2}{2[pointE_input.power.limit]^2}$ versus time.

3 SAR Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedure for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating $f < 3GHz$ is used as an example to detail the test procedures in this chapter.

3.1 Test configuration selection criteria for validating Smart Transmit feature

For validating Smart Transmit feature, this section provides a general guidance to select test cases. In practice, an adjustment can be made in test case selection. The



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

justification/clarification may be provided.

3.1.1 Test configuration selection for change in time window

FCC specifies different time window for time averaging based on operation frequency. The criteria to select a test configuration for validating Smart Transmit feature and demonstrating the compliance during the change in time window is

- Select any technology/band that has operation frequency classified in one time window defined by FCC (such as 100s time window), and its corresponding Plimit is less than Pmax if possible.
- Select the 2nd technology/band that has operation frequency classified in a different time window defined by FCC (such as 60s time window), and its corresponding Plimit is less than Pmax if possible.
- It is preferred both Plimit values of two selected technology/bands are less than corresponding Pmax, but if not possible or due to limitation of test setup, then at least one of technologies/bands has its Plimit less than Pmax.
- Else, if all Plimit > Pmax, then,
 - ✓ First select both technologies/bands (one is in 100s time window, another is in 60s time window) having (Plimit – Pmax) < 2.2dB; if it is not available, then
 - ✓ Select at least one technology/band in 60s time window having (Plimit – Pmax) < 2.2dB; if it is not available, then
 - ✓ Test for change in time window is not required.

Use the highest measured 1g_or_10g SAR at Plimit (Plimit < Pmax) shown in Part 1 report for the selected tech/band/antenna/DSI out of all radio configurations and device positions in Equation (3a), (5a) and (6a) to calculate time-varying SAR. However, in the case of Plimit > Pmax, the SAR measured in Part 1 report for the corresponding radio configuration selected and tested in Part 2 should be applied in Equation (3a), (5a) and (6a).

This test is performed with the EUT being requested to transmit at maximum power in selected technology/band. Test for one pair of time windows selected is sufficient as the feature operation is the same.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

3.1.2 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover:

1. SAR exposure switch when two active radios are at the same time window.
2. SAR exposure switch when two active radios are in different time windows.
One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. 5G NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + 5G NR transmission) is sufficient, where the SAR exposure varies among SAR_{radio1} only, $SAR_{radio1} + SAR_{radio2}$, and SAR_{radio2} only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE+5G NR).
- Among all supported simultaneous transmission configurations, the selection order is

1. select one configuration where both P_{limit} of radio1 and radio2 is less than their corresponding P_{max} , preferably, with different P_{limits} . If this configuration is not available, then,
2. select one configuration that has P_{limit} less than its P_{max} for at least one

radio. If this cannot be found, then,

3. select one configuration that has P_{limit} of radio1 and radio2 greater than P_{max} but with least $(P_{limit} - P_{max})$ delta.

Test for one simultaneous transmission scenario is sufficient as the feature operation is the same.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.ssgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

3.2 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

3.2.1 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging windows of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz.

To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 2 can be written as follows for transmission scenario having change in time window,

$$1gSAR_1(t) = \frac{\text{conducted_Tx_power_1}(t)}{\text{conducted_Tx_power_P}_{limit_1}} * 1g_or\ 10g_SAR_P_{limit_1} \quad (7a)$$

$$1gSAR_2(t) = \frac{\text{conducted_Tx_power_2}(t)}{\text{conducted_Tx_power_P}_{limit_2}} * 1g_or\ 10g_SAR_P_{limit_2} \quad (7b)$$

$$\frac{1}{T1_{SAR}} \left[\int_{t-T1_{SAR}}^{t_1} \frac{1g_or\ 10g_SAR_1(t)}{FCC\ SAR\ limit} dt \right] + \frac{1}{T2_{SAR}} \left[\int_{t-T2_{SAR}}^t \frac{1g_or\ 10g_SAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \quad (7c)$$

where, conducted_Tx_power_1(t), conducted_Tx_power_P_{limit_1}(t), and 1g_or 10g_SAR_P_{limit_1} correspond to the instantaneous Tx power, conducted Tx power at P_{limit}, and compliance 1g_or 10g_SAR values at P_{limit_1} of band1 with time-averaging window 'T1_{SAR}'; conducted_Tx_power_2(t), conducted_Tx_power_P_{limit_2}(t), and 1g_or 10g_SAR_P_{limit_2} correspond to the instantaneous Tx power, conducted Tx power at P_{limit}, and compliance 1g_or 10g_SAR values at P_{limit_2} of band2 with time-averaging window 'T2_{SAR}'. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window 'T1_{SAR}' to the second band with time-averaging window 'T2_{SAR}' happens at time-instant 't₁'.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to radio2 P_{limit} . If radio2 is dependent on radio1 (for example, non-standalone mode of 5G NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 5G NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set Reserve_power_margin to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.
4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg or 10gSAR_{limit} of 4.0W/kg.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 83071443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

3.2.2 SAR exposure switching

This test is to demonstrate that Smart Transmit feature is accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. Here, radio1 represents primary radio (for example, LTE anchor in a NR non-standalone mode call) and radio2 represents secondary radio (for example, 5G NR). The detailed test procedure for SAR exposure switching in the case of LTE+5G NR non-standalone mode transmission scenario is provided in Appendix B.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to radio2 P_{limit} . If radio2 is dependent on radio1 (for example, non-standalone mode of 5G NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 5G NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set Reserve_power_margin to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.

4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

3.3 Test procedure for time-varying SAR measurements

This section provides general time-varying SAR measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

To perform the validation through SAR measurement for transmission scenario 1 described in Section 2, the “path loss” between callbox antenna and EUT needs to be calibrated to ensure that the EUT Tx power reacts to the requested power from callbox in a radiated call. It should be noted that when signaling in closed loop mode, protocol-level power control is in play, resulting in EUT not solely following callbox TPC (Tx power control) commands. In other words, EUT response has many dependencies (RSSI, quality of signal, path loss variation, fading, etc.) other than just TPC commands. These dependencies have less impact in conducted setup (as it is a controlled environment and the path loss can be very well calibrated) but have significant impact on radiated testing in an uncontrolled environment, such as SAR test setup. Therefore, the deviation in EUT Tx power from callbox requested power is expected, however the time-averaged SAR should not exceed FCC SAR requirement at all times as Smart Transmit controls Tx power at EUT.

The following steps are for time averaging feature validation through SAR measurement:

1. “Path Loss” calibration: Place the EUT against the phantom in the worst-case position determined based on Section 3.2.1. For each band selected, prior to SAR measurement, perform “path loss” calibration between callbox antenna and EUT. Since the SAR test environment is not controlled and well calibrated for OTA (Over the Air) test, extreme care needs to be taken to avoid the influence from reflections. The test setup is described in Section 6.1.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

2. Time averaging feature validation:

- i For a given radio configuration (technology/band) selected in Section 3.2.1, enable Smart Transmit and set *Reserve_power_margin* to 0 dB, with callbox to request maximum power, perform area scan, conduct pointSAR measurement at peak location of the area scan. This point SAR value, *pointSAR_P_{limit}*, corresponds to point SAR at the measured *P_{limit}* (i.e., measured *P_{limit}* from the EUT in Step 1 of Section 3.3.1).
- ii Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit. Note, if *Reserve_power_margin* cannot be set wirelessly, care must be taken to re-position the EUT in the exact same position relative to the SAM phantom as in above Step 2.i. Establish radio link in desired radio configuration, with callbox requesting the EUT's Tx power at power levels described by test sequence 1 generated in Step 1 of Section 3.3.1, conduct point SAR measurement versus time at peak location of the area scan determined in Step 2.i of this section. Once the measurement is done, extract instantaneous point SAR vs time data, *pointSAR(t)*, and convert it into instantaneous 1gSAR or 10gSAR vs. time using Eq. (3a), re-written below:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR_P_{limit}$$

where, *pointSAR_P_{limit}* is the value determined in Step 2.i, and *pointSAR(t)* is the instantaneous point SAR measured in Step 2.ii, *1g_or_10gSAR_P_{limit}* is the measured 1gSAR or 10gSAR value listed in Part 1 report.

- iii Perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time.
- iv Make one plot containing: (a) time-averaged 1gSAR or 10gSAR versus time determined in Step 2.iii of this section, (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.
- v Repeat 2.ii ~ 2.iv for test sequence 2 generated in Step 1 of Section 3.3.1.
- vi Repeat 2.i ~ 2.v for all the technologies and bands selected in Section 3.2.1.

The time-averaging validation criteria for SAR measurement is that, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (3b)).



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

4 Test Configurations

4.1 WWAN (sub-6) transmission

The Plimit values, corresponding to SAR_design_target, for technologies and bands supported by EUT are derived in Part 0 report and summarized in Table 4-1.

Table 4-1: Plimit for supported technologies and bands (Plimit in EFS file)

Band	Mode	Antenna	P _{max} *	P _{limit} (average)				
				Head	Body Worn		Hotspot	Limbs
				DSI 2	DSI 4 (Ant11/12/21/23/31/41)	DSI 7 (Ant13/101)	DSI 6	DSI 4
GSM 850	GPRS 2TS	11#	24.5	21.5	24.5	/	23.0	24.5
	GPRS 4TS		24.0	21.5	24.0	/	23.0	24.0
	GPRS 2TS	31#	24.5	24.5	24.5	/	23.5	24.5
	GPRS 4TS		24.0	24.0	24.0	/	23.5	24.0
GSM 1900	GPRS 2TS	13#	21.5	17.5	/	21.5	20.0	21.5
	GPRS 4TS		21.0	17.5	/	21.0	20.0	21.0
	GPRS 2TS	41#	21.5	21.5	21.5	/	20.0	21.5
	GPRS 4TS		21.0	21.0	21.0	/	20.0	21.0
WCDMA_B2	RMC	13#	22.5	16.0	/	23.0	19.5	21.0
	RMC	41#	22.0	22.0	21.0	/	20.5	21.0
WCDMA_B4	RMC	13#	23.5	16.0	/	22.5	21.0	20.0
	RMC	41#	23.5	23.5	20.0	/	18.5	20.0
WCDMA_B5	RMC	11#	23.5	20.0	23.0	/	21.5	23.0
	RMC	31#	23.5	23.5	22.0	/	21.5	22.0
CDMA_BC0	RMC	11#	23.0	20.0	22.0	/	20.5	22.0
	RMC	31#	23.5	23.5	23.5	/	23.5	23.5
LTE_B2	QPSK	13#	23.5	17.5	/	23.5	20.0	21.5
	QPSK	41#	23.7	23.7	21.2	/	20.7	21.2
	QPSK	12#	23.5	19.5	21.5	/	20.0	21.5
LTE_B4	QPSK	13#	23.5	16.5	/	23.0	19.5	20.5
	QPSK	41#	23.5	23.5	21.0	/	20.0	21.0
	QPSK	12#	23.5	20.0	21.5	/	20.0	21.5
LTE_B5	QPSK	11#	23.9	20.4	23.4	/	21.9	23.4
	QPSK	31#	23.5	23.5	22.5	/	22.5	22.5
LTE_B7	QPSK	13#	23.0	15.0	/	22.0	18.5	20.0
	QPSK	41#	23.3	23.3	20.8	/	19.3	20.8
	QPSK	12#	23.3	17.3	21.3	/	19.3	21.3
LTE_B12	QPSK	11#	23.4	23.4	23.4	/	23.4	23.4
	QPSK	31#	23.0	23.0	23.0	/	23.0	23.0
LTE_B13	QPSK	11#	23.4	23.4	23.4	/	23.4	23.4
	QPSK	31#	23.0	23.0	23.0	/	23.0	23.0
LTE_B17	QPSK	11#	23.0	23.0	23.0	/	23.0	23.0
	QPSK	31#	23.0	23.0	23.0	/	23.0	23.0
LTE_B26	QPSK	11#	23.0	20.5	23.0	/	22.0	23.0
	QPSK	31#	23.0	23.0	23.0	/	23.0	23.0
LTE_B38	QPSK	13#	24.0	17.0	/	24.0	20.0	21.5



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 83071443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com



Doc No./Rev.: SGS-W-TRF-101 v00

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch

Report No.: SZCR240400116010
Page : 15 of 39

	QPSK	41#	24.0	24.0	22.5	/	21.5	22.5
LTE_B41	QPSK	13#	24.0	17.0	/	24.0	20.0	21.5
	QPSK	41#	24.0	24.0	22.5	/	21.5	22.5
LTE_B66	QPSK	13#	23.5	16.5	/	23.0	20.0	20.5
	QPSK	41#	23.5	23.5	21.0	/	20.0	21.0
NR5G_N2	QPSK	13#	23.5	17.0	/	23.5	20.5	22.0
	QPSK	41#	23.5	23.5	21.0	/	20.5	21.0
NR5G_N5	QPSK	12#	23.5	20.5	21.0	/	19.5	21.0
	QPSK	11#	23.9	20.4	23.4	/	22.9	23.4
NR5G_N7	QPSK	31#	23.5	23.5	22.5	/	22.5	22.5
	QPSK	13#	23.0	13.5	/	21.0	18.0	19.5
NR5G_N26	QPSK	41#	23.3	23.3	19.8	/	18.3	19.8
	QPSK	12#	23.3	16.8	20.8	/	19.8	20.8
NR5G_N38	QPSK	11#	23.5	21.5	23.5	/	22.5	23.5
	QPSK	31#	23.5	23.5	23.5	/	23.5	23.5
NR5G_N41 PC2	QPSK	13#	23.5	14.7	/	23.5	18.2	19.7
	QPSK	41#	23.5	23.5	20.2	/	19.2	20.2
NR5G_N41 PC3	QPSK	12#	23.8	17.5	21.5	/	20.5	21.5
	QPSK	13#	25.2	14.7	/	18.2	18.2	19.7
NR5G_N66	QPSK	41#	25.0	25.2	19.7	/	18.7	19.7
	QPSK	12#	25.5	17.5	21.5	/	20.5	21.5
NR5G_N77 PC3	QPSK	13#	22.2	14.7	/	21.5	18.2	19.7
	QPSK	41#	22.0	22.0	19.5	/	18.5	19.5
NR5G_N78 PC2	QPSK	12#	22.5	17.5	21.5	/	20.5	21.5
	QPSK	13#	23.0	15.0	/	22.0	18.5	19.5
NR5G_N78 PC3	QPSK	41#	23.0	23.0	21.0	/	20.5	21.0
	QPSK	12#	23.0	20.0	21.5	/	20.0	21.5
NR5G_N77 PC3	QPSK	13#	23.5	17.0	s	23.5	20.5	21.0
	QPSK	21#	23.5	17.5	19.5	/	18.5	19.5
NR5G_N78 PC2	QPSK	23#	23.5	16.5	17.0	/	15.5	17.0
	QPSK	101#	23.5	20.5	/	23.5	19.5	20.5
NR5G_N78 PC3	QPSK	101#	25.5	21.5	/	24.5	19.0	21.5
	QPSK	23#	24.5	18.0	18.5	/	17.0	18.5
NR5G_N78 PC3	QPSK	13#	23.2	17.2	/	24.7	22.2	23.2
	QPSK	21#	25.0	17.5	20.5	/	19.5	20.5
NR5G_N78 PC3	QPSK	101#	22.5	21.5	/	23.5	19.0	21.5
	QPSK	23#	21.5	18.0	18.5	/	17.0	18.5
NR5G_N78 PC3	QPSK	13#	20.2	17.2	/	21.7	21.7	21.7
	QPSK	21#	22.0	17.5	20.5	/	19.5	20.5

*Pmax is used for RF tune up procedure. The maximum allowed output power is equal to Pmax + device uncertainty.

Uncertainty dB (k=2)	All Band
Total uncertainty	1.49

To account for total uncertainty, SAR_design_target should be determined as:

$$SAR_{design_target} < SAR_{regulatory_limit} \times 10^{\frac{-total\ uncertainty}{10}}$$



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

Exposure position	Frequency band	SAR Regulatory Limit W/kg(1g)	SAR design target W/kg(1g)
Head	WWAN	1.6	0.6
Body worn	WWAN	1.6	0.6
Hotsopt	WWAN	1.6	0.6
Exposure position	Frequency band	SAR Regulatory Limit W/kg(10g)	SAR design target W/kg(10g)
Limbs	WWAN	4.0	2.0



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch
Business Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

Table4-2: Radio configurations selected for Part 2 test

Test case No.	Test scenario	Part 2 test configurations								Part 1 worst-case ratio config 1g SAR measured at P _{limit}
		Tech	Band	Ant	DSI	RB/offset	Channel/Freq (MHz)	position	Distance (mm)	
1	Time Windows Switch (100-60-100)	sub6 NR	N7	Ant13	DSI2	QPSK 108_54	507000/2535	Right tilted	0mm	0.459
		sub6 NR	N77	Ant13	DSI2	QPSK 1_137	633334/3500	Right cheek	0mm	0.591
2	Time Windows Switch (60-100-60)	sub6 NR	N77	Ant13	DSI2	QPSK 1_137	633334/3500	Right cheek	0mm	0.591
		sub6 NR	N7	Ant13	DSI2	QPSK 108_54	507000/2535	Right tilted	0mm	0.459
3	SAR1 vs SAR2	N2_4A	LTE Band 4	Ant41	DSI6	QPSK 1_0	132322/1745	Bottom side	10mm	0.388
		N2_4A	N2	Ant13	DSI6	QPSK 50_28	380000/1900	Top side	10mm	0.371
4	SAR1 vs SAR2	LTE	LTE Band 2	Ant13	DSI2	QPSK 50_0	18900/1880	Right cheek	0mm	0.526
		LTE	LTE Band 5	Ant11	DSI2	QPSK 36_0	26765/821.5	Right cheek	0mm	0.346

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 4-2. The corresponding worst-case radio configuration 1gSAR or 10gSAR values for selected technology/band/DSI are extracted from Part 1 report and are listed in the last column of Table 4-2.

Based on equations (1a) and (3a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/DSI. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a) and (3a), the accuracy in compliance demonstration remains the same.

Based on the selection criteria described in Section 3.2, the radio configurations for the Tx varying transmission test cases listed in Section 2 are:

1. Technologies and bands for change in time-window: The test case 5 listed in Table 4-2 is selected for time window switch between 60s window (NR N77) and 100s window (NR N7) in conducted power setup. NR N7 is using different antenna from NR N77, so this test also address the antenna change.
2. Technologies and bands for switch in SAR exposure: The test case 6-7 listed in Table 4-2 are selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + 5G NR active or LTE Inter-Band Uplink CA active, in conducted power setup.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation

5.1 Measurement setup

The Rohde & Schwarz callbox is used in this test. The test setup schematic are shown in Figures 6-1. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler. For antenna & technology switch measurement, two ports (RF1 COM and RF3 COM) of the callbox used for signaling two different technologies are connected to a combiner, which is in turn connected to a directional coupler. The other end of the directional coupler is connected to a splitter to connect to two RF ports of the EUT corresponding to the two antennas of interest. In both the setups, power meter is used to tap the directional coupler for measuring the conducted output power of the EUT. For time averaging validation test (Section 3.3.1), call drop test (Section 3.3.2), and DSI switch test (Section 3.3.4), only RF1 COM port of the callbox is used to communicate with the EUT. For technology/band switch measurement (Section. 3.3.3), both RF1 COM and RF3 COM port of callbox are used to switch from one technology communicating on RF1 COM port to another technology communicating on RF3 COM port. All the path losses from RF port of EUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

Sub6 NR test setup:

The Keysight UXME7515B callbox is used in this test. The test setup schematic are shown in Figures 6-1. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler.

LTE+5G NR test setup:

The Keysight UXME7515B callbox is used in this test. If LTE conducted port and 5G NR conducted port are same on this EUT (i.e., they share the same antenna), therefore, low-/high-pass filter are used to separate LTE and 5G NR signals for power meter measurement via directional couplers, as shown in below Figure 6-1 C (Appendix F – Test Setup Photo).

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

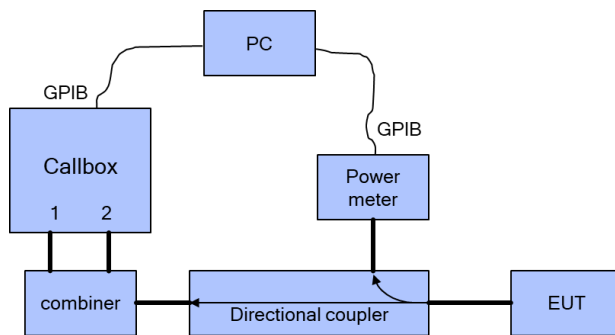


Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

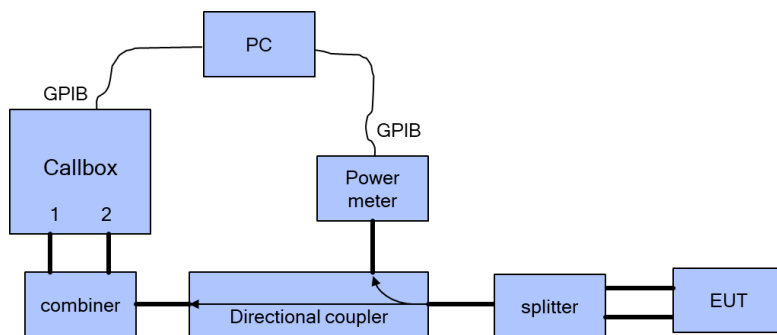
Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)



(a)



(b)



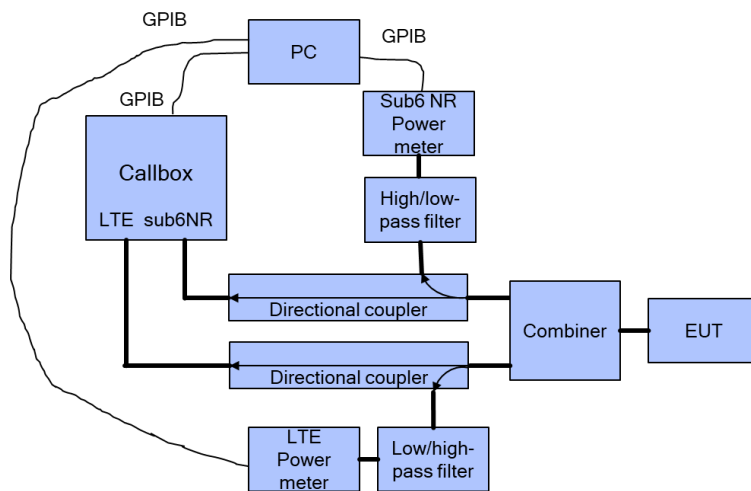
Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
 Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)



(c)

Figure 5-1 Conducted power measurement setup

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 500 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox's requested power versus time, while at the same time to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0dBm for 100 seconds
- test sequence 1 or test sequence 2 (defined in Section 3.1 and generated in Section 3.2.1), for 360 seconds
- stay at the last power level of test sequence 1 or test sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power.

For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at $P_{reserve}$ level. See Section 3.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

5.2 Plimit and Pmax measurement results

The measured P_{limit} for all the selected radio configurations given in Table 4-2 are listed in below Table. P_{max} was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 3.

Table5-1: Measured Plimit and Pmax of selected radio configurations

Test case No.	Test scenario	Tech	Band	Ant	DSI	RB/offset	Channel/Freq (MHz)	position	Distance (mm)	Pmax EFS setting(dBm)	Plimit EFS setting(dBm)	Measured Pmax (dBm)	Measured Plimit (dBm)
1	Time Windows Switch (100-60-100)	sub6 NR	N7	Ant13	DSI2	QPSK 108_54	507000/2535	Right tilted	0mm	23.0	13.5	22.22	12.69
		sub6 NR	N77	Ant13	DSI2	QPSK 1_137	633334/3500	Right cheek	0mm	23.5	17.0	22.65	16.05
2	Time Windows Switch (60-100-60)	sub6 NR	N77	Ant13	DSI2	QPSK 1_137	633334/3500	Right cheek	0mm	23.5	17.0	22.65	16.05
		sub6 NR	N7	Ant13	DSI2	QPSK 108_54	507000/2535	Right tilted	0mm	23.0	13.5	22.22	12.69
3	SAR1 vs SAR2	N2_4A	LTE Band 4	Ant41	DSI6	QPSK 1_0	132322/1745	Bottom side	10mm	23.5	20.0	23.35	19.69
		N2_4A	N2	Ant13	DSI6	QPSK 50_28	380000/1900	Top side	10mm	23.5	20.5	23.82	20.61
4	SAR1 vs SAR2	LTE	LTE Band 2	Ant13	DSI2	QPSK 50_0	18900/1880	Right cheek	0mm	23.5	17.5	23.66	17.52
		LTE	LTE Band 5	Ant11	DSI2	QPSK 36_0	26765/821.5	Right cheek	0mm	23.9	20.4	23.12	19.44



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch/SGS-CSTC Standards Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

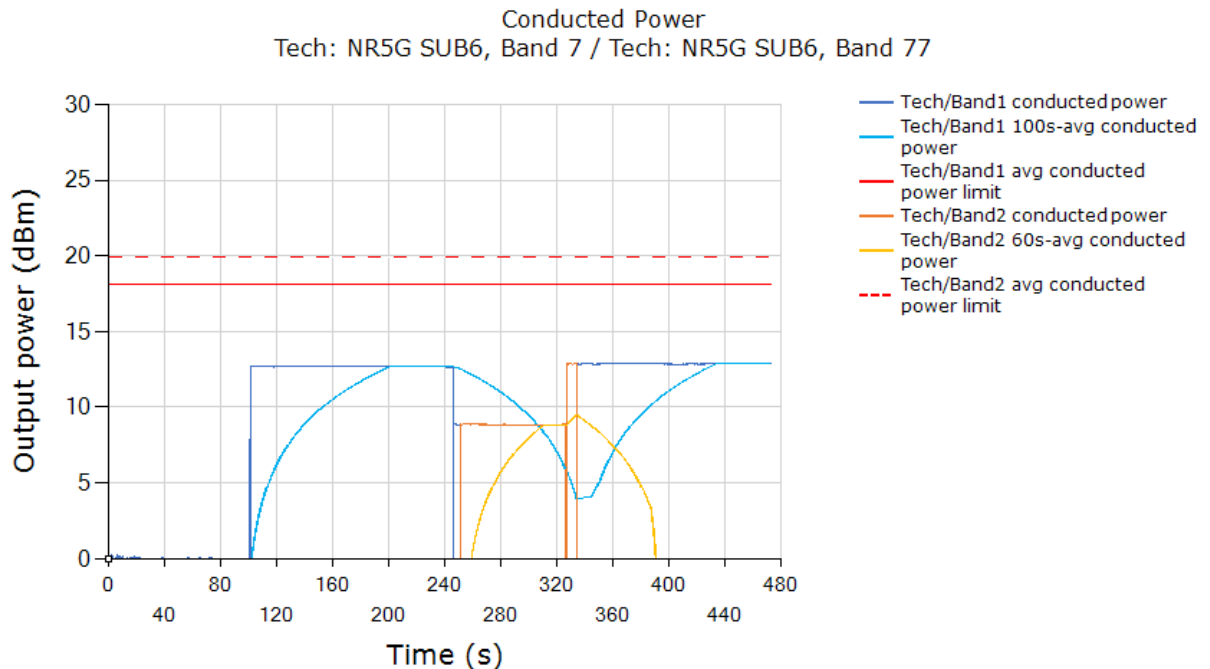
Member of the SGS Group (SGS SA)

5.3 Change in Time window

5.3.1 Test case 1: transition from NR N7 to NR N77 (i.e., 100s to 60s), then back to NR N7

Test result for change in time-window (from 100s to 60s to 100s):

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when NR N7 switches to NR N77 (~245 seconds timestamp) and switches back to NR N7 (~310 seconds timestamp): switch measurement is performed with the EUT in various SAR exposure scenarios.



Plot Notes: The conducted power plot shows expected transitions in Tx power at ~245 seconds (100s-to-60s transition) and at ~310 seconds (60s-to-100s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next

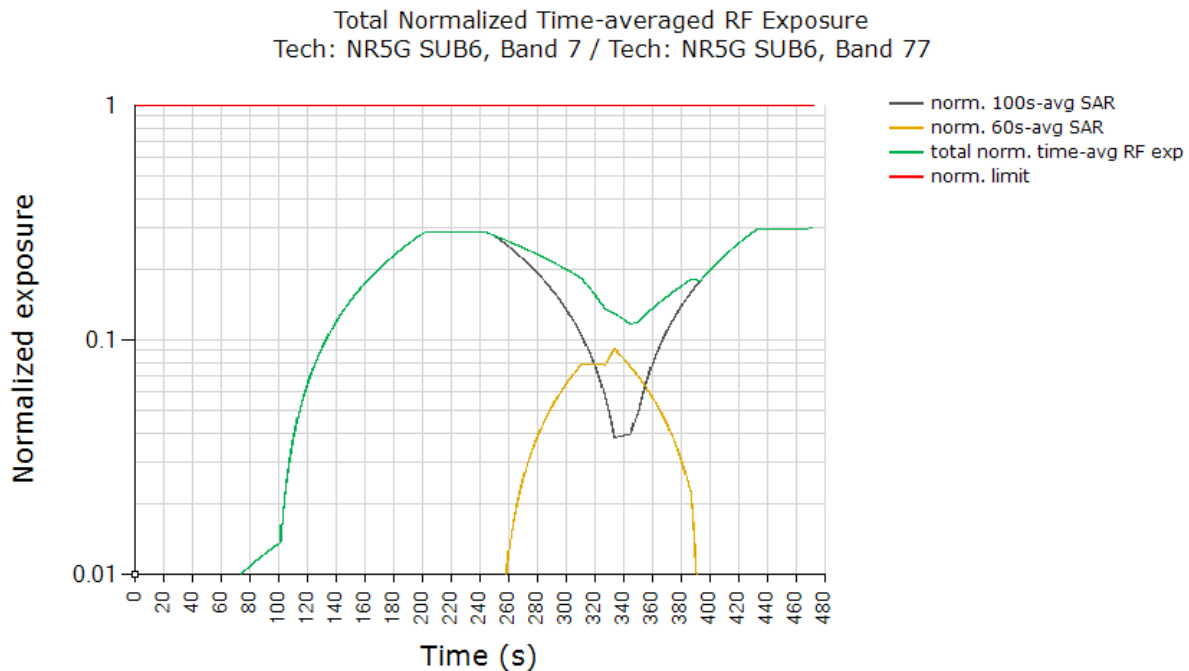


Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in NR N7 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in NR N77 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves)



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.299
Validated	



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Plot Notes:

Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 100s-to-60s window at ~245s time stamp, and from 60s-to-100s window at ~310s time stamp. Smart Transmit controls the Tx power during these time window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1.49dB device uncertainty. In this test, with a maximum normalized SAR of 0.299 being ≤ 0.528 ($=0.6/1.6 + 1.49\text{dB}$ device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

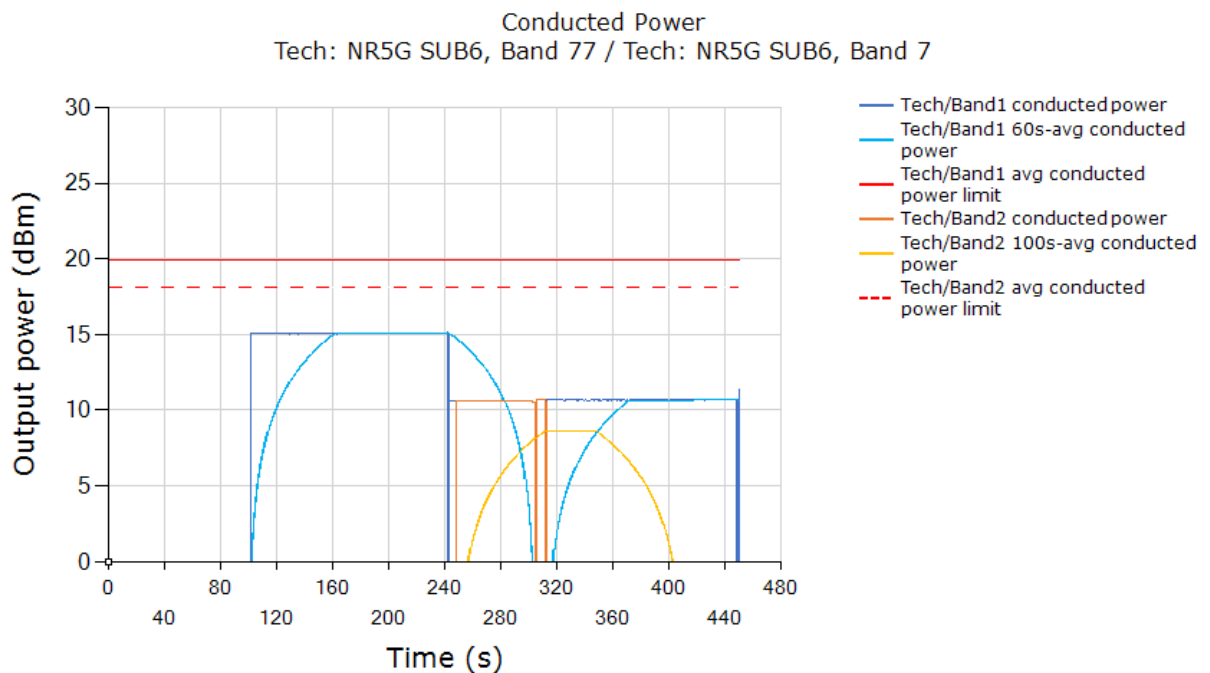
SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

5.3.2 Test case 1: transition from NR N78 to NR N41 (i.e., 60s to 100s), then back to NR N78

Test result for change in time-window (from 60s to 100s to 60s):

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when NR N77 switches to NR N7 ((~185 seconds timestamp) and switches back to NR N77 (~290 seconds timestamp): switch measurement is performed with the EUT in various SAR exposure scenarios.



Plot Notes: The conducted power plot shows expected transitions in Tx power at ~245 seconds (60s-to-100s transition) and at ~290 seconds (100s-to-60s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next



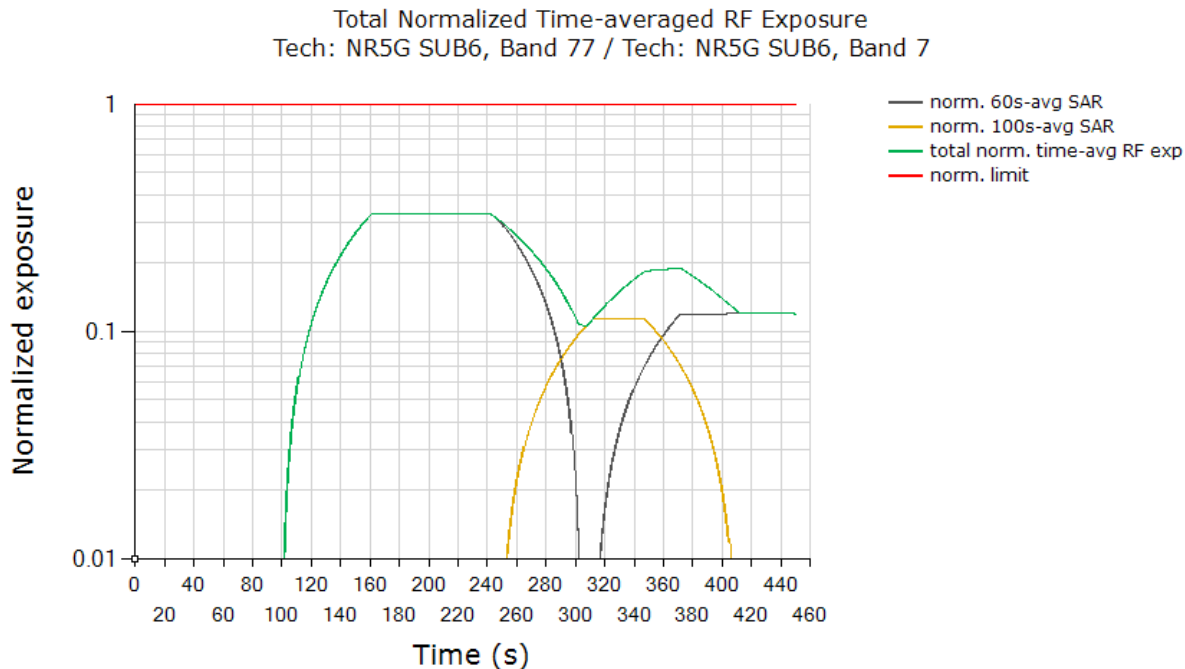
Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in NR N7 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in NR N77 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves)



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.330
Validated	



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Plot Notes:

Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 1 60s-to-100s window at ~185s time stamp, and from 100s-to-60s window at ~290s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1.49dB device uncertainty. In this test, with a maximum normalized SAR of 0.330 being ≤ 0.528 ($=0.6/1.6 + 1.49\text{dB}$ device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

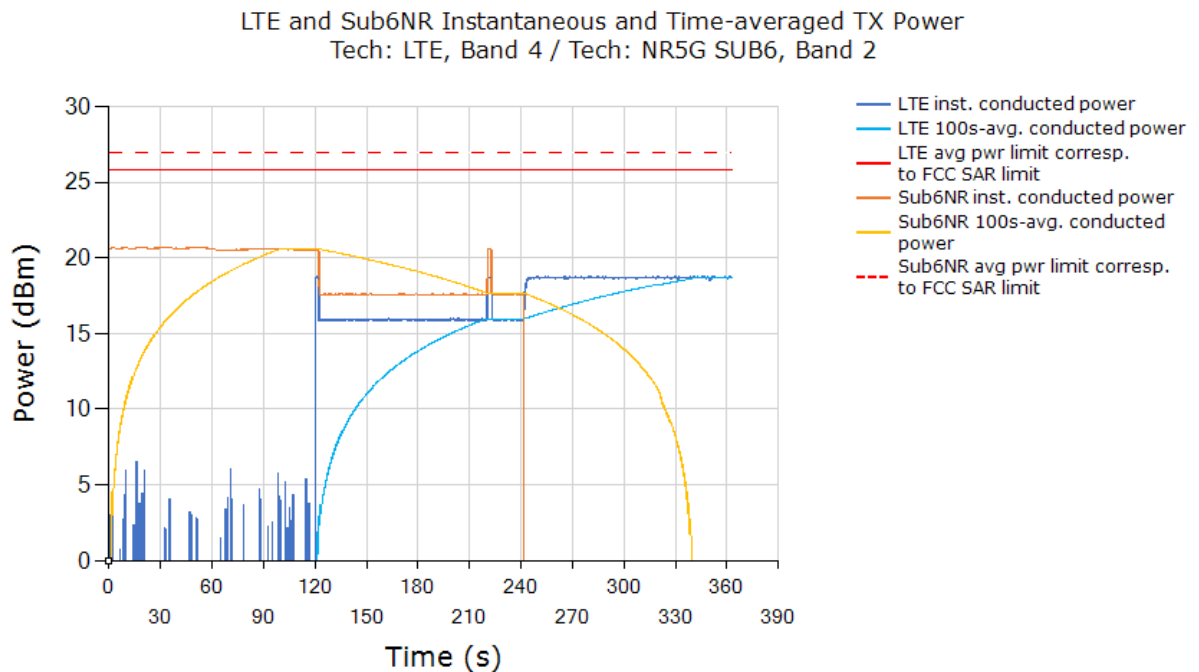
Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

5.4 Switch in SAR exposure test results (EN-DC Combination)

This test was conducted with callbox requesting maximum power, and with the EUT in LTE Band 4 + Sub6 NR Band 2 call. The SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios.



Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the limit of 1 unit. Equation is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE B4 as shown in black curve. Similarly, equation is used to obtain 60s-averaged normalized SAR in Sub6 NR n2 as shown in orange curve. Equation is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).

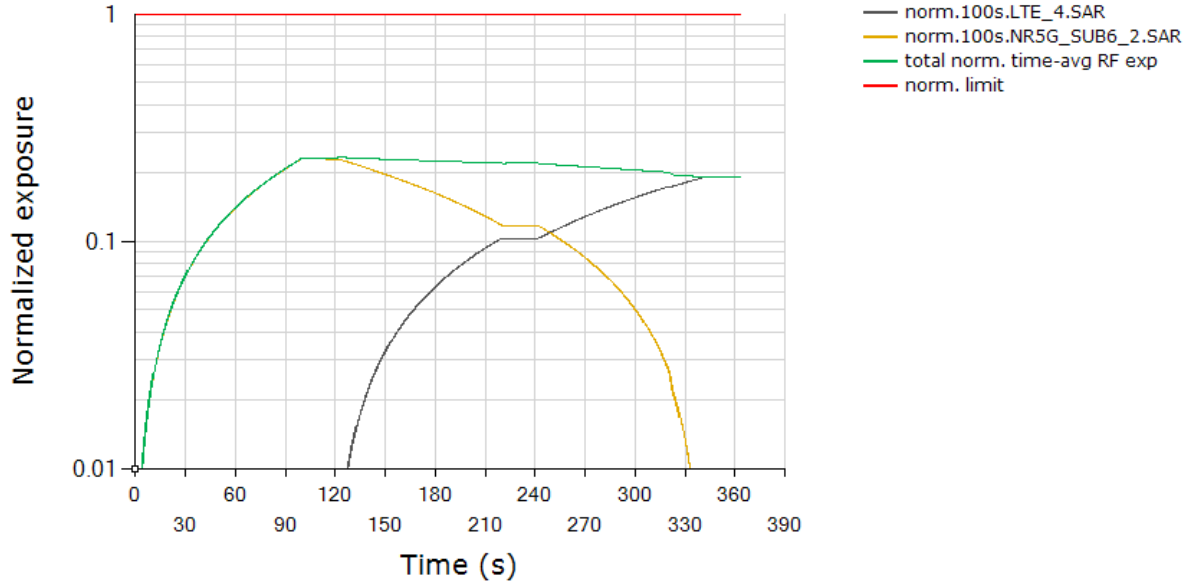


Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Total Normalized Time-averaged RF Exposure
 Tech: LTE, Band 4 / Tech: NR5G SUB6, Band 2



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.235
Validated	

The above test result validated the continuity of power limiting in SAR exposure switch scenario.

Plot Notes:

Device starts predominantly in 5G NR SAR exposure scenario between 0s and 120s, and in LTE SAR + 5G NR SAR exposure scenario between 120s and 240s, and in predominantly in LTE SAR exposure scenario after t=240s. Here, Smart Transmit allocates a maximum of 100% of exposure margin (based on reserve margin setting) for 5G NR. This corresponds to a normalized 1gSAR exposure value = 0.231 W/kg measured SAR at 5G NR Plimit / 1.6W/kg limit = 0.232+ “+1.49dB~ -1.49dB” device related uncertainty (see orange curve between 0s~120s). For predominantly LTE SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.193W/kg



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 83071443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
 Shenzhen Branch

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

measured SAR at LTE Plimit /1.6W/kg limit = 0.243+ “+1.49dB~ -1.49dB” device related uncertainty (see black curve after t = 240s). Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target +1.49dB device uncertainty. In this test, with a maximum normalized SAR of 0.235 being ≤ 0.528 ($=0.6/1.6 +1.49\text{dB}$ device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

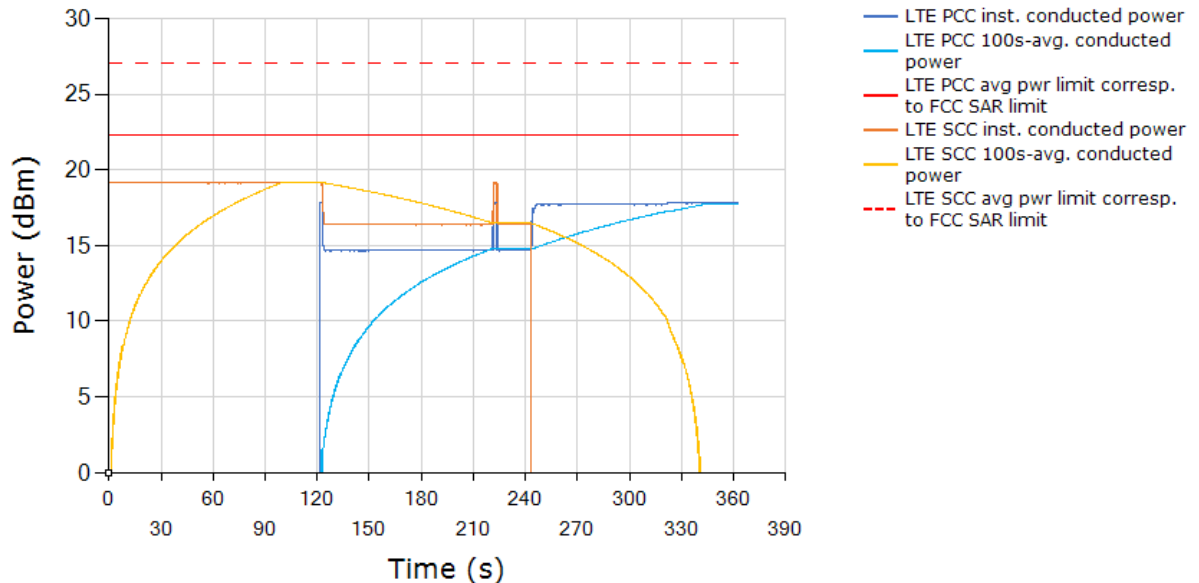
SGS-CSTC Standards Technical Services Co., Ltd.
 Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

5.5 Switch in SAR exposure test results (LTE Inter-Band Uplink CA)

This test was conducted with callbox requesting maximum power, and with the EUT in LTE UL CA B2 + LTE UL CA B5 call. Following procedure detailed in Section 3.3.5 and Appendix C, and using the measurement setup shown in Figure 5-1, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios.

LTE PCC/SCC Instantaneous and Time-averaged TX Power
 Tech: LTE, Band 2 / Tech: LTE, Band 5

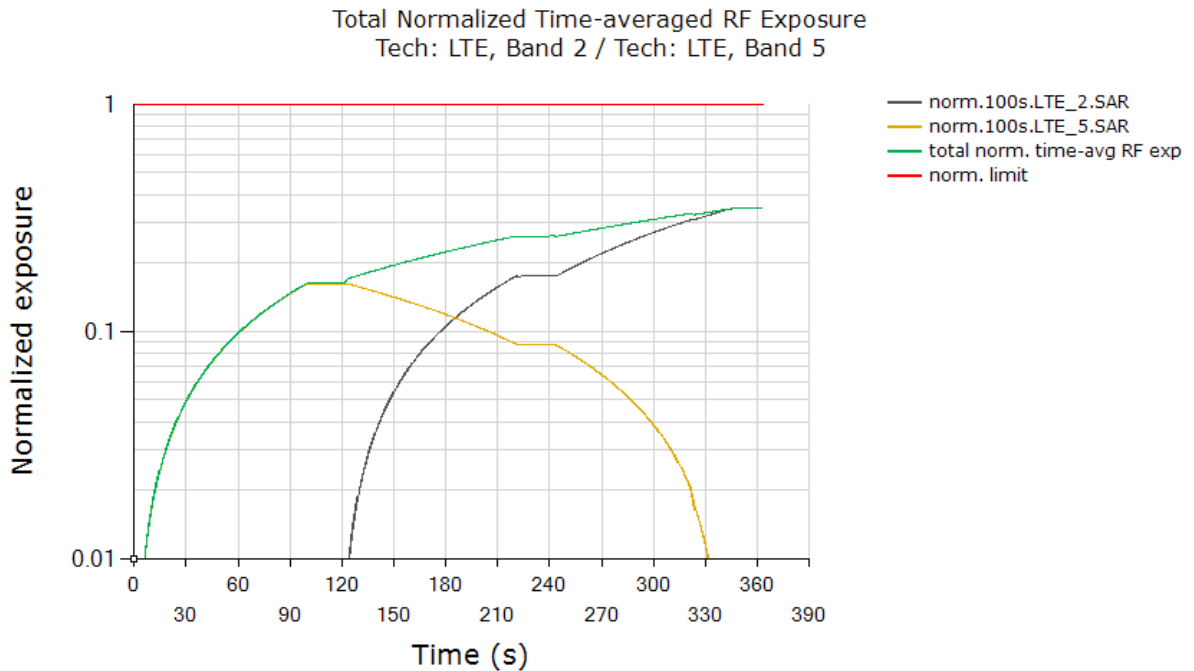


Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (6a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE UL CA B2 PCC as shown in black curve. Similarly, equation (6b) is used to obtain 100s-averaged normalized SAR in LTE UL CA B5 SCC as shown in orange curve. Equation (6c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.349
Validated	

Plot Notes:

Device starts predominantly in SCC SAR exposure scenario between 0s and 120s, and in PCC SAR + SCC SAR exposure scenario between 120s and 240s, and in predominantly in PCC SAR exposure scenario after t=240s. Between 0s and 120s, PCC is at



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

low power, however, SCC Tx power leakage (~30dB lower) due to filter/directional coupler characteristics in the measurement setup is shown as PCC power in the plot. Similarly, PCC leakage is shown as SCC power after t=240s. For predominantly PCC SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.348 W/kg measured SAR at LTE Plimit / 1.6W/kg limit = 0.329 +1.49dB device related uncertainty (see black curve after t = 240s).

Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target + device uncertainty. In this test, with a maximum normalized SAR of 0.349 being ≤ 0.528 (=0.6/1.6 +1.49dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch, Wireless Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

6 Conclusions

Qualcomm Smart Transmit feature employed has been validated through the conducted/radiated power measurement. As demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios described in Section 2. Therefore, the EUT complies with FCC RF exposure requirement.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Docheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
 Shenzhen Branch, Business Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
 中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

7 Test Equipment List

Test Platform		SPEAG DASY Professional				
Description		SAR Test System				
Software Reference		cDASY8 V16.2.4.2524				
Hardware Reference						
Equipment		Manufacturer	Model	Serial Number	Calibration Date	Due date of calibration
☒	Universal Radio Communication Tester	R&S	CMW500	171428	2023/05/11	2024/05/10
☒	UXM Wireless Test Platform	Keysight	E7515B	MY59150869	2023/09/14	2024/09/13
☒	Power Sensor	R&S	NRP8S	104926	2023/12/21	2024/12/20
☒	Power Sensor	R&S	NRP8S	105296	2023/12/21	2024/12/20
☒	RF Coupler	Narda	4216-10	01703	NCR	NCR
☒	RF Coupler	Narda	4216-10	01442	NCR	NCR
☒	Humidity and Temperature Indicator	CHIGAO	HTC-1	ZGL2020120550471	2023/05/26	2024/05/25

Note: All the equipment are within the valid period when the tests are performed.

Appendix A. Test Procedures for 5G NR + LTE Radio

Appendix B provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + 5G NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor.

Time-varying Tx power test for 5G NR in NSA mode

Follows Section 3.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 3.1) applied to 5G NR (with LTE on all-down bits or low power for the entire test after establishing the LTE+5G NR call with the callbox). Follow the test procedures described in Section 3.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of 5G NR when converted into 1gSAR values does not exceed the regulatory limit at all times (see Eq. (1a) and (1b)). 5G NR response to test sequence1



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Standards Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Member of the SGS Group (SGS SA)

and test sequence2 will be similar to other technologies (say, LTE), and are shown in Sections 6.3.7 and 6.3.8.

Switch in SAR exposure between LTE vs. 5G NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and 5G NR, and SAR from 5G NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE and 5G NR in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to 5G NR P_{limit} . If testing LTE+5G NR in non-standalone mode, then establish LTE+5G NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from 5G NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set Reserve_power_margin to actual (intended) value with EUT setup for LTE + 5G NR call. First, establish LTE connection in all-up bits with the callbox, and then 5G NR connection is added with callbox requesting UE to transmit at maximum power in 5G NR. As soon as the 5G NR connection is established, request all-down bits on LTE link (otherwise, 5G NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE (all-down bits)+5G NR transmission for more than one time-window duration to test predominantly 5G NR SAR exposure scenario (as SAR exposure is negligible from all-down bits in LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR and 5G NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) 5G NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and 5G NR for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and 5G NR links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1gSAR value (see Eq. (6a))



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing / inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgs.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform 100s running average to determine time-averaged 1gSAR versus time as illustrated in Figure 3-1.

4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (b) corresponding regulatory 1gSAR_{limit} of 1.6W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR versus time shall not exceed the regulatory 1gSAR_{limit} of 1.6W/kg.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

SGS-CSTC Standards Technical Services Co., Ltd.
Shenzhen Branch Technical Services Laboratory

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

Appendix C. Test Procedures for inter-band UL CA

Appendix C provides the test procedures for validating Qualcomm Smart Transmit feature for Switch in SAR exposure between PCC vs. SCC during inter-band ULCA transmission mode transmission scenario.

Switch in SAR exposure between PCC vs. SCC during inter-band ULCA transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for PCC radio only, SAR from both PCC & SCC radios, and SAR from SCC radio only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure *Plimit* for PCC and SCC in selected band. Test condition to measure conducted *Plimit* is:
 - Establish a LTE call with single active Tx in desired PCC band. Measure conducted Tx power corresponding to LTE *Plimit* with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure *Plimit* corresponding to LTE SCC band under single active Tx scenario.
2. Set *Reserve_power_margin* to actual (intended) value, with EUT setup for interband ULCA call. First, establish interband ULCA connection with the callbox, and as soon as the connection is established, request all-down bits (or low power) on PCC link and then request UE to transmit at maximum power in SCC link. Continue PCC (all-down bits)+SCC transmission for more than one time-window duration to test predominantly SCC SAR exposure scenario (as SAR exposure from PCC is negligible from all-down bits). After at least one time-window, request PCC to go all-up bits to test PCC SAR and SCC SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) SCC transmission to test predominantly PCC SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both PCC and SCC for the entire duration of this test.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com

3. Once the measurement is done, extract instantaneous Tx power versus time for both PCC and SCC links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1g_or_10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band *Plimit* measured in Step 1, and then perform 100s running average to determine time-averaged 1g_or_10gSAR versus time as illustrated in Figure 5-1. Note that here it is assumed both radios have Tx frequencies < 3GHz, otherwise, 60s running average should be performed for radios having Tx frequency between 3GHz and 6GHz.
4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory 1g_or_10gSARlimit limit.
The validation criteria is, at all times, the time-averaged 1g_or_10gSAR versus time shall not exceed the regulatory 1g_or_10gSARlimit limit.



Unless otherwise agreed in writing, this document is issued by the Company subject to its General Conditions of Service printed overleaf, available on request or accessible at <https://www.sgs.com/en/Terms-and-Conditions>. Attention is drawn to the limitation of liability, indemnification and jurisdiction issues defined therein. Any holder of this document is advised that information contained hereon reflects the Company's findings at the time of its intervention only and within the limits of Client's instructions, if any. The Company's sole responsibility is to its Client and this document does not exonerate parties to a transaction from exercising all their rights and obligations under the transaction documents. This document cannot be reproduced except in full, without prior written approval of the Company. Any unauthorized alteration, forgery or falsification of the content or appearance of this document is unlawful and offenders may be prosecuted to the fullest extent of the law. Unless otherwise stated the results shown in this test report refer only to the sample(s) tested and such sample(s) are retained for 30 days only.

Attention: To check the authenticity of testing /inspection report & certificate, please contact us at telephone: (86-755) 8307 1443, or email: CN.Doccheck@sgs.com

No.1 Workshop, M-10, Middle Section, Science & Technology Park, Nanshan District, Shenzhen, Guangdong, China 518057 t (86-755) 26012053 www.sgsgroup.com.cn
中国·广东·深圳市南山区科技园中区M-10栋1号厂房 邮编: 518057 t (86-755) 26012053 sgs.china@sgs.com